



ALPHA & OMEGA
SEMICONDUCTOR

AON6294

100V N-Channel AlphaMOS

General Description

- Latest Trench Power AlphaMOS (α MOS MV) technology
- Very Low $R_{DS(ON)}$
- Low Gate Charge
- Optimized for fast-switching applications
- RoHS and Halogen-Free Compliant

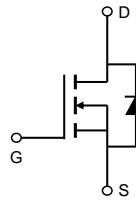
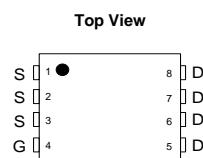
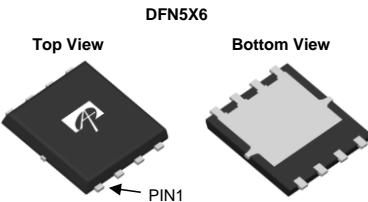
Application

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

| | |
|---------------------------------|----------------|
| V_{DS} | 100V |
| I_D (at $V_{GS}=10V$) | 52A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 10m Ω |
| $R_{DS(ON)}$ (at $V_{GS}=6V$) | < 14m Ω |

100% UIS Tested
100% Rg Tested



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AON6294 | DFN5x6 | Tape & Reel | 3000 |

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units | |
|--|------------------|-------------|-------|---|
| Drain-Source Voltage | V_{DS} | 100 | V | |
| Gate-Source Voltage | V_{GS} | ± 20 | V | |
| Continuous Drain Current | $T_C=25^\circ C$ | 52 | A | |
| Current | | 33 | | |
| Pulsed Drain Current ^C | I_{DM} | 80 | | |
| Continuous Drain Current | $T_A=25^\circ C$ | 17 | A | |
| Current | | 14 | | |
| Avalanche Current ^C | I_{AS} | 33 | A | |
| Avalanche energy L=0.1mH ^C | E_{AS} | 54 | mJ | |
| V_{DS} Spike | 10 μs | V_{SPIKE} | 120 | V |
| Power Dissipation ^B | $T_C=25^\circ C$ | 57 | W | |
| | | 23 | | |
| Power Dissipation ^A | $T_A=25^\circ C$ | 6.2 | W | |
| | | 4.0 | | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C | |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A $t \leq 10s$ | $R_{\theta JA}$ | 15 | 20 | °C/W |
| Maximum Junction-to-Ambient ^{A,D} Steady-State | | 40 | 50 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 1.8 | 2.2 | °C/W |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 100 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=100\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | 1 | 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$ | | | ±100 | nA |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 2.4 | 2.95 | 3.5 | V |
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | 8.4 | 10 | 15.5 | $\text{m}\Omega$ |
| | | $V_{GS}=6\text{V}, I_D=20\text{A}$ | | 11 | 14 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=20\text{A}$ | | 34 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}, V_{GS}=0\text{V}$ | | 0.72 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 52 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=50\text{V}, f=1\text{MHz}$ | | 2265 | | pF |
| C_{oss} | Output Capacitance | | | 195 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 10 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | 0.7 | 1.5 | 2.3 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=20\text{A}$ | | 28 | 40 | nC |
| Q_{gs} | Gate Source Charge | | | 10 | | nC |
| Q_{gd} | Gate Drain Charge | | | 4 | | nC |
| $t_{D(\text{on})}$ | Turn-On DelayTime | $V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=2.5\Omega, R_{\text{GEN}}=3\Omega$ | | 10.5 | | ns |
| t_r | Turn-On Rise Time | | | 4 | | ns |
| $t_{D(\text{off})}$ | Turn-Off DelayTime | | | 20 | | ns |
| t_f | Turn-Off Fall Time | | | 4.5 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$ | | 35 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$ | | 195 | | nC |

A. The value of R_{QJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on $R_{\text{QJA}} \leq 10\text{s}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$.

D. The R_{QJA} is the sum of the thermal impedance from junction to case R_{QJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

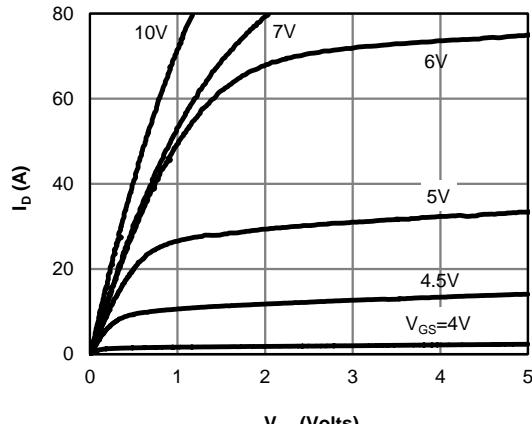
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{DS} (Volts)
Figure 1: On-Region Characteristics (Note E)

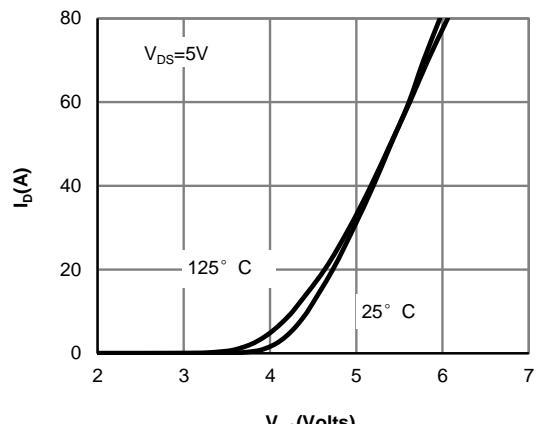


Figure 2: Transfer Characteristics (Note E)

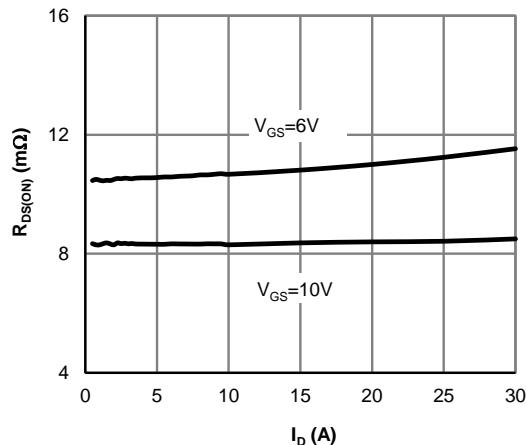


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

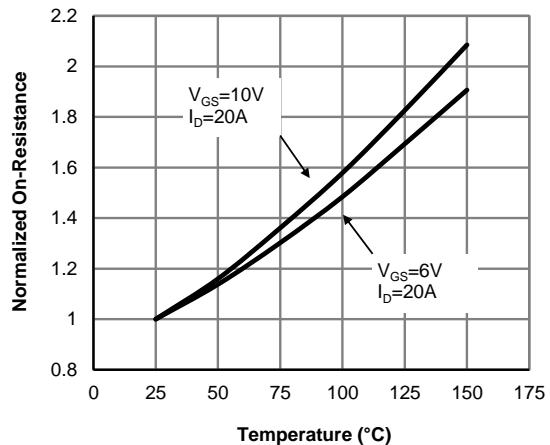
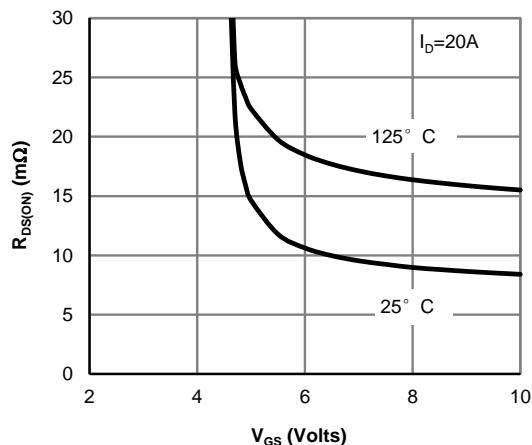


Figure 4: On-Resistance vs. Junction Temperature (Note E)



**Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)**

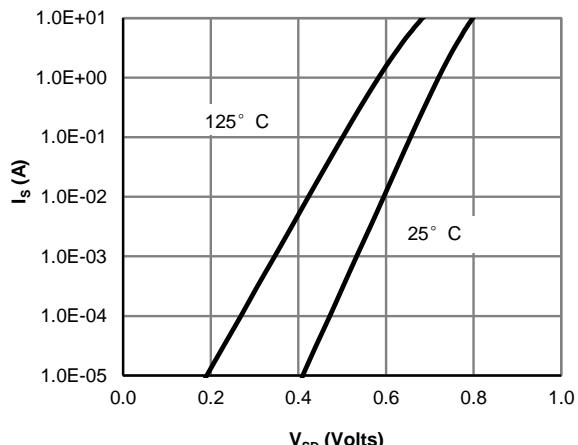
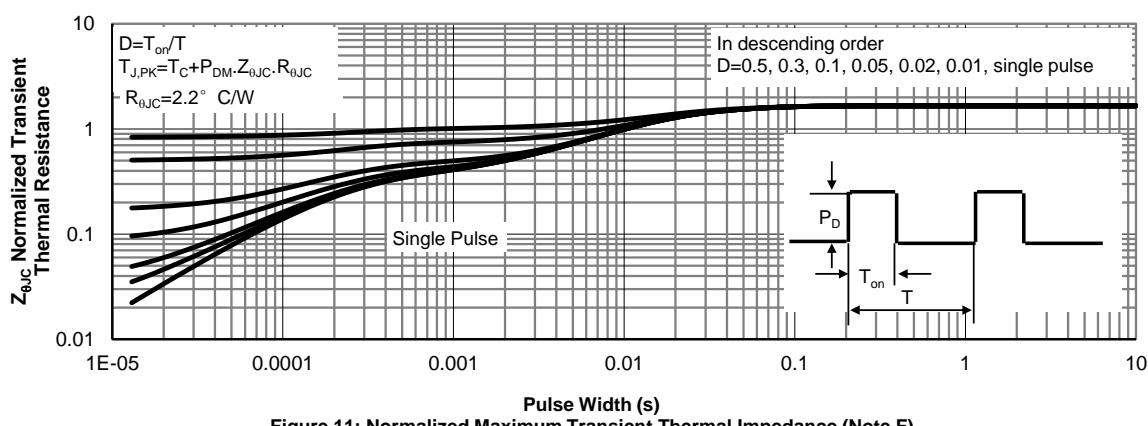
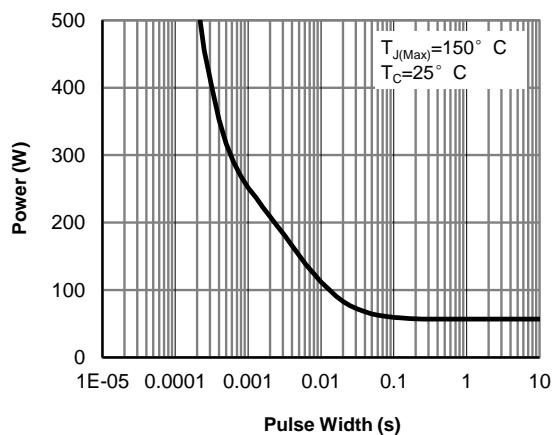
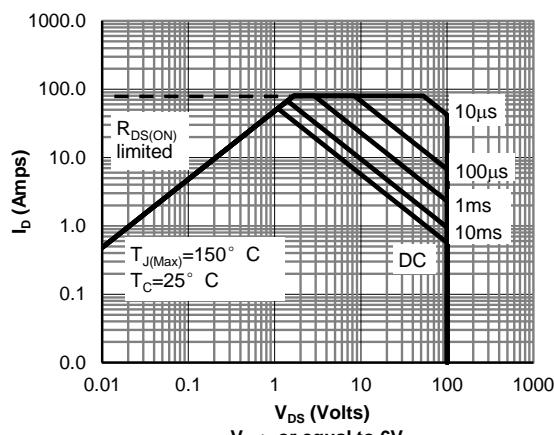
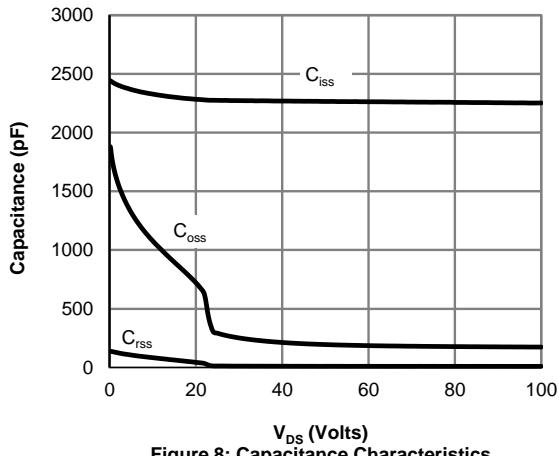
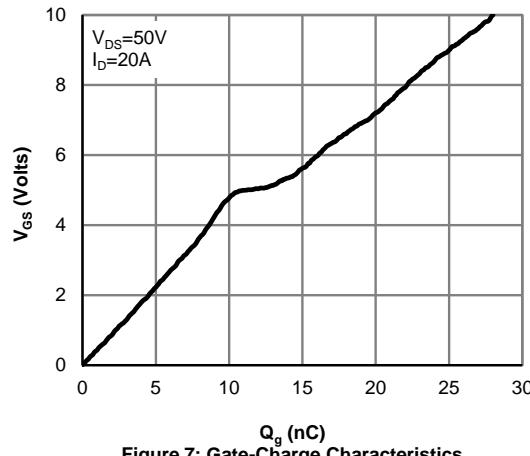
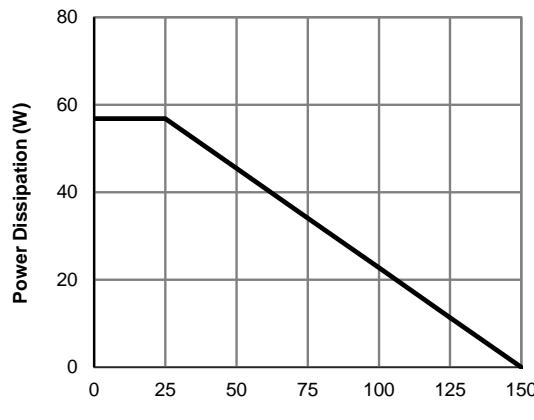
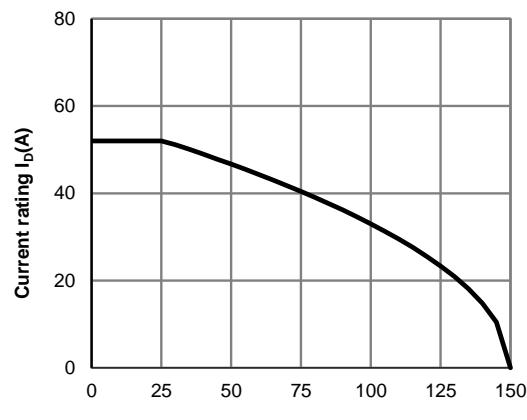
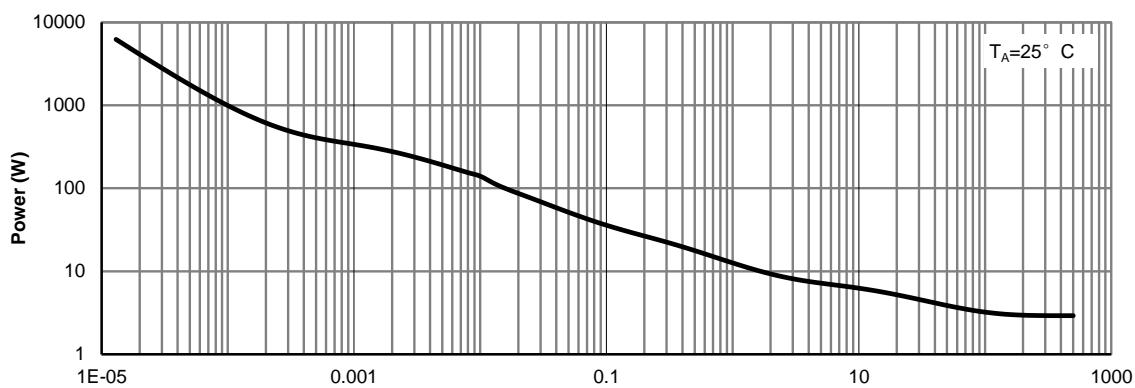
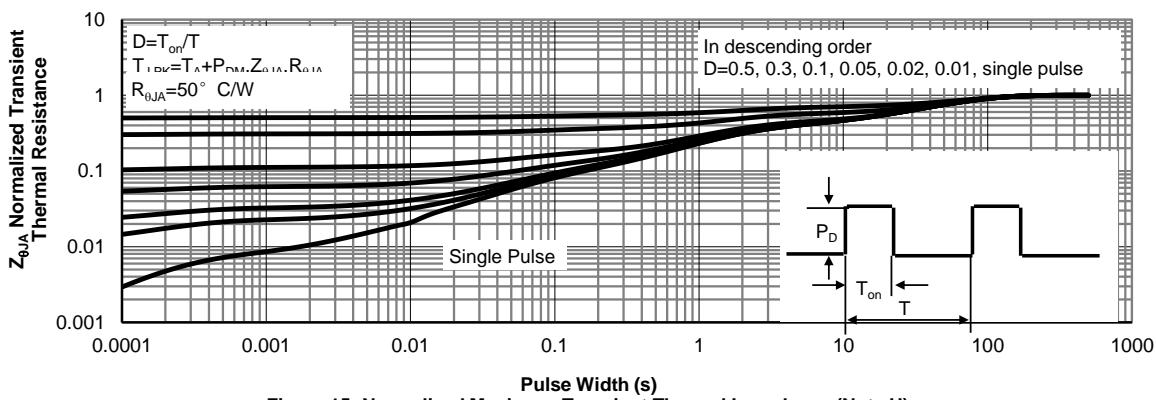
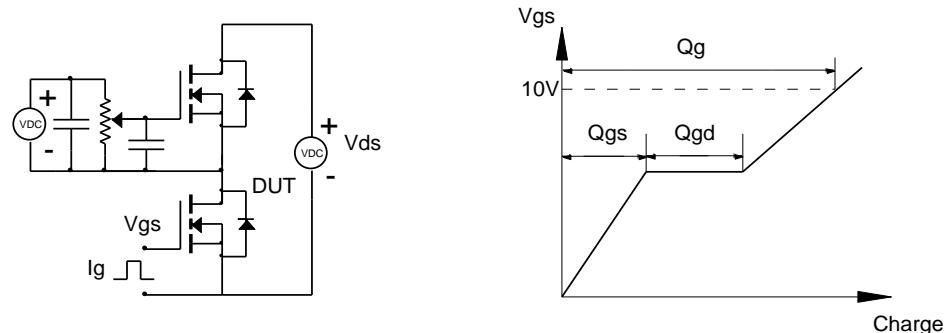
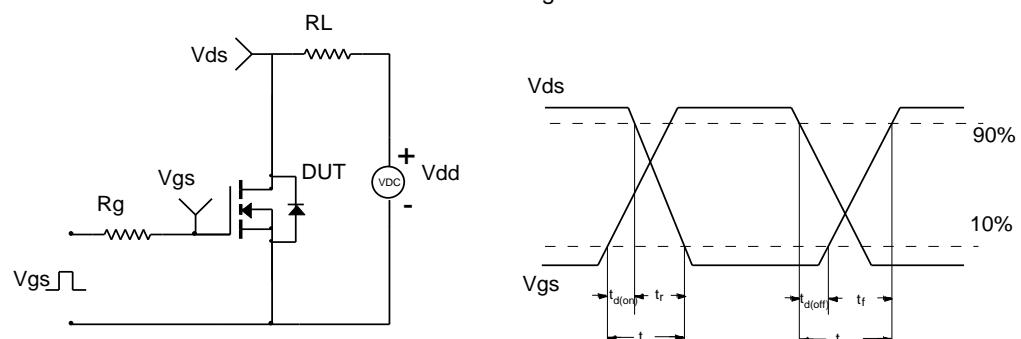
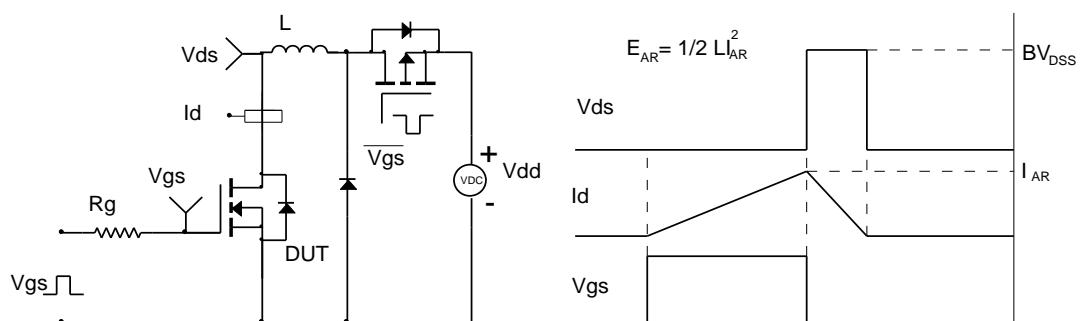


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


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Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
